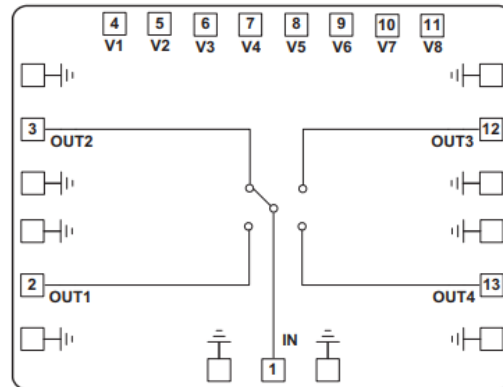


**Features**

- Isolation: >40dB @ 20GHz
- Insertion Loss: 2.8dB @ 20GHz
- Absorptive design:
- Die Size: 2x 1.5 x 0.1 mm

**Typical Applications**

- TTL compatible driver included
- Fast Switching Speed
- Low Insertion Loss and High Isolation
- Customization available upon request

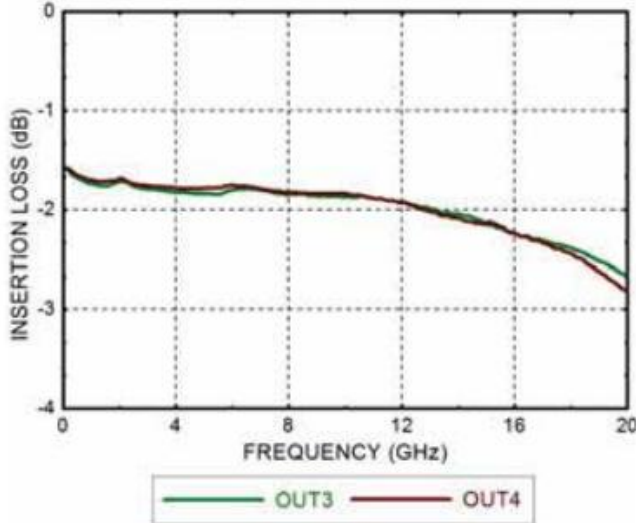
**Functional Block Diagram**

**Electrical Specifications**

TA = +25°C, Vctl = 0/-5V

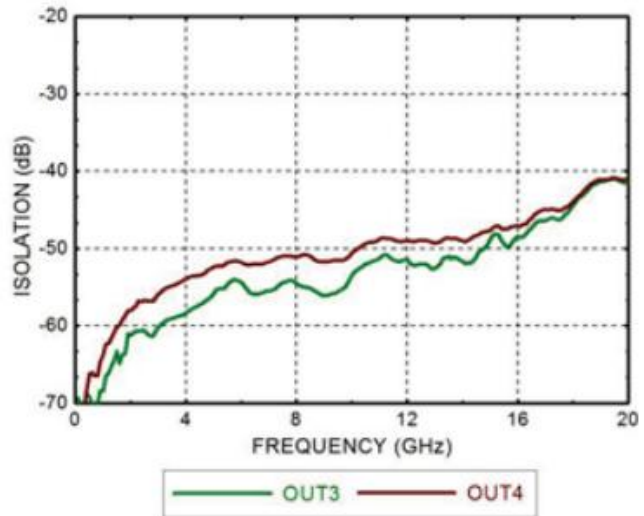
Parameters	Min.	Typ.	Max.	Units
Frequency	DC - 20			GHz
Insertion Loss		2.8		dB
Isolation		45		dB
Return Loss (ON State)		16		dB
Return Loss (OFF State)		15		dB
Input 1dB Compression (P1dB)		25		dBm
Switching Speed		15		ns



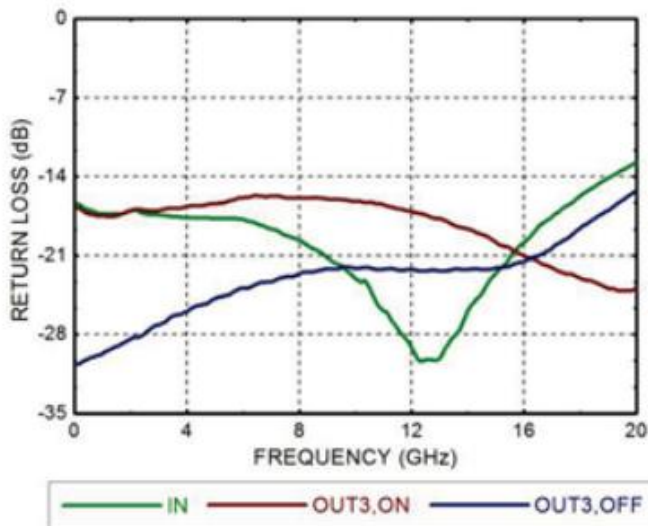
### Insertion Loss



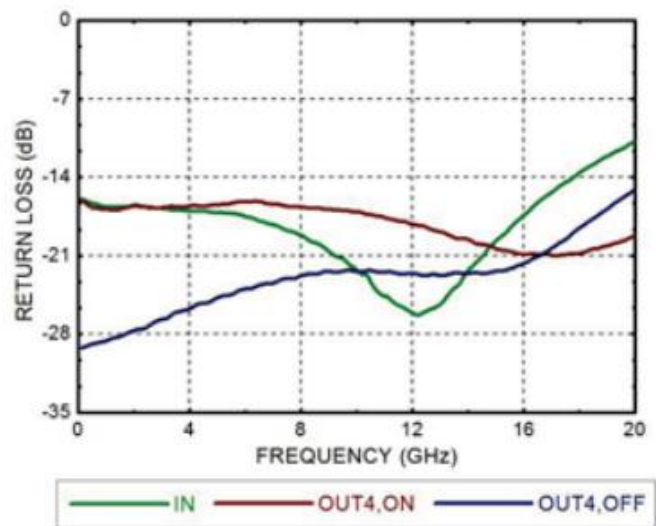
### Isolation



### OUT3 Return Loss



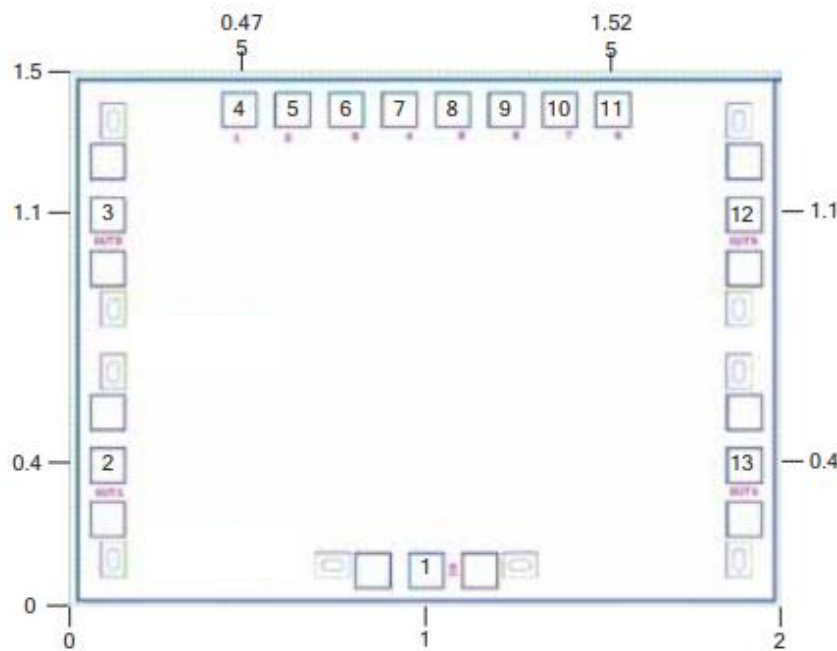
### OUT4 Return Loss





### Outline Drawing:

All Dimensions in mm

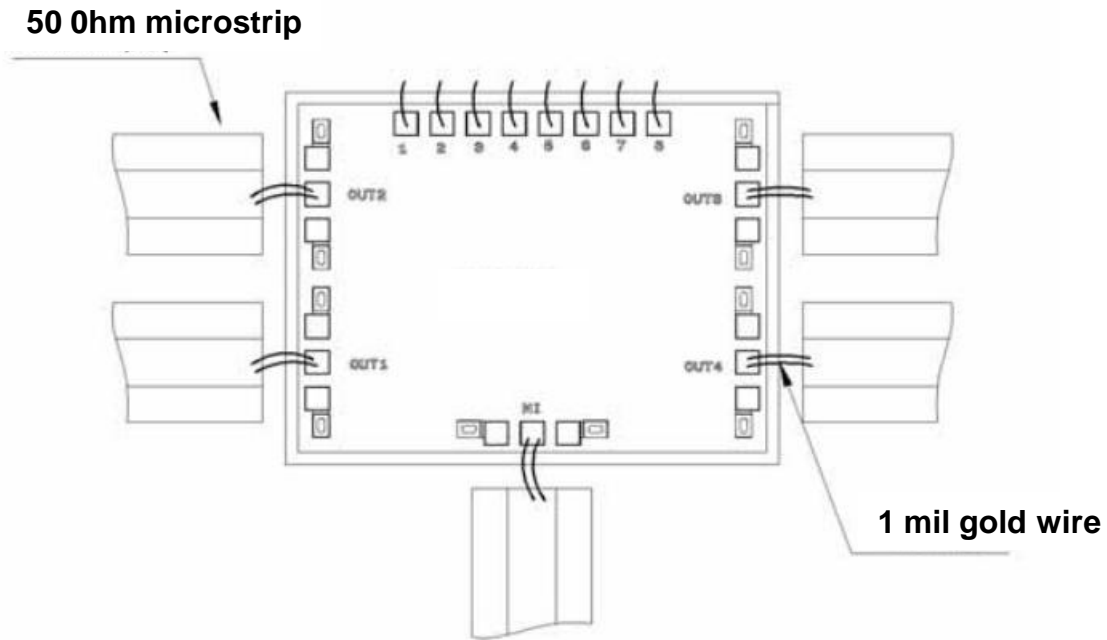


### Pad Description

PAD	Function	Description
1	IN	The pad is DC coupled to 50 ohms . If the RF level is not 0V, then the blocking capacitor is required externally.
2,3,12,13	OUT1, OUT2 OUT3, OUT4	The pad is DC coupled to 50 ohms . If the RF level is not 0V, then the blocking capacitor is required externally.
4-11	V1-V8	When V1/V4/V6/V8=-5V,V2/V3/V5/V7=0V,The OUT1 is "ON" state; When V2/V3/V6/V8=-5V,V1/V4/V5/V7=0V, The OUT2 is "ON" state; When V2/V4/V5/V8=-5V,V1/V3/V6/V7=0V, The OUT3 is "ON" state; When V2/V4/V6/V7=-5V,V1/V3/V5/V8=0V, The OUT4 is "ON" state
Die Bottom	GND	Die bottom must be connected to RF/DC ground



### Assembly Drawing



#### Notes:

1. Die thickness: 100um
2. Typical bond pad is 100\*100  $\mu\text{m}^2$
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

#### Maximum Ratings:

1. RF input power: +27dBm
2. Storage temperature: -65°C to +175°C
3. Operating temperature: -55°C to +85°C